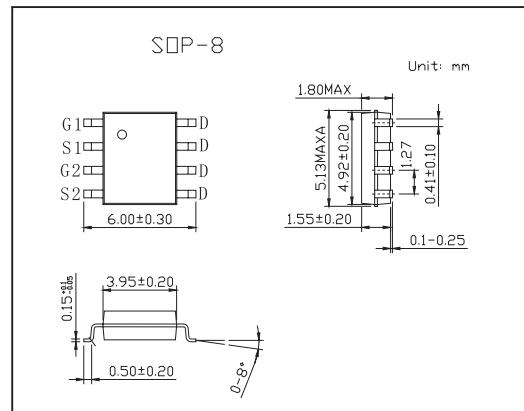
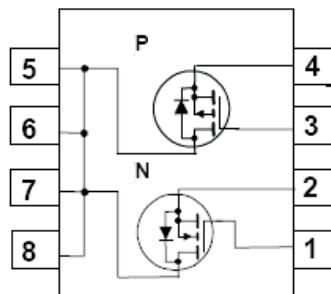


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■ Features

- N-Ch $R_{DS(ON)} = 54\text{m}\Omega$ @ $V_{GS} = 2.5\text{V}$
 $3.6\text{A}, 20\text{V}$ $R_{DS(ON)} = 38\text{m}\Omega$ @ $V_{GS} = -4.5\text{V}$
- P-Ch $R_{DS(ON)} = 110\text{m}\Omega$ @ $V_{GS} = -2.5\text{V}$
 $-2.6\text{A}, -20\text{V}$ $R_{DS(ON)} = 80\text{m}\Omega$ @ $V_{GS} = -4.5\text{V}$
- Fast switching speed
- High performance trench technology for extremely low $R_{DS(ON)}$



■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	N-Channel	P- Channel	Unit	
Drain to Source Voltage	V_{DSS}	20	-20	V	
Gate to Source Voltage	V_{GS}	± 12	± 8	V	
Drain Current Continuous (Note 1a)	I_D	3.6	-2.6	A	
Drain Current Pulsed		15	-10	A	
Power Dissipation for Single Operation (Note 1a)	P_D	0.8			W
Operating and Storage Temperature	T_J, T_{STG}	-55 to 150			°C
Thermal Resistance Junction to Ambient (Note 1a)	$R_{\theta JA}$	146			°C/W
Thermal Resistance Junction to Ambient (Note 1b)	$R_{\theta JA}$	76			°C/W
Thermal Resistance Junction to Case (Note 1)	$R_{\theta JC}$	40			°C/W

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 ■ Electrical Characteristics $T_a = 25^\circ C$

Parameter	Symbol	Testconditons			Min	Typ	Max	Unit	
Drain-Source Breakdown Voltage	V_{BDSS}	$V_{GS} = 0 V$, $I_D = 250 \mu A$	N-Ch	20				V	
		$V_{GS} = 0 V$, $I_D = -250 \mu A$		-20					
Breakdown Voltage Temperature Coefficient	$\frac{\Delta V_{BDSS}}{\Delta T_J}$	$I_D = 250 \mu A$, Referenced to $25^\circ C$	N-Ch		36			$mV/^\circ C$	
		$I_D = -250 \mu A$, Referenced to $25^\circ C$		P-Ch		-15			
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 16V$, $V_{GS} = 0 V$	N-Ch			1		μA	
		$V_{DS} = -16 V$, $V_{GS} = 0 V$		P-Ch			-1		
Gate-Body Leakage	I_{GSS}	$V_{GS} = \pm 12 V$, $V_{DS} = 0 V$	N-Ch			± 100		nA	
		$V_{GS} = \pm 8 V$, $V_{DS} = 0 V$		P-Ch			± 100		
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	N-Ch	0.6	0.8	1.5		V	
		$V_{DS} = V_{GS}$, $I_D = -250 \mu A$		P-Ch	-0.4	-0.7	-1.6		
Gate Threshold Voltage Temperature Coefficient	$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	$I_D = 250 \mu A$, Referenced to $25^\circ C$	N-Ch			-2		$mV/^\circ C$	
		$I_D = -250 \mu A$, Referenced to $25^\circ C$		P-Ch		2.5			
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 4.5 V$, $I_D = 3.6 A$	N-Ch		31	38		$m\Omega$	
		$V_{GS} = 2.5 V$, $I_D = 3.1 A$			42	54			
		$V_{GS} = 4.5 V$, $I_D = 3.6 A$, $T_J = 125^\circ C$			41	58			
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = -4.5 V$, $I_D = -2.6 A$	P-Ch		66	80			
		$V_{GS} = -2.5 V$, $I_D = -2.2 A$			85	110			
		$V_{GS} = -4.5 V$, $I_D = -2.6 A$, $T_J = 125^\circ C$			83	108			
On-State Drain Current	$I_{D(on)}$	$V_{GS} = 4.5 V$, $V_{DS} = 5V$	N-Ch	10				A	
		$V_{GS} = -4.5 V$, $V_{DS} = -5V$		P-Ch	-10				
Forward Transconductance	g_{FS}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	N-Ch		15			S	
		$V_{DS} = V_{GS}$, $I_D = -250 \mu A$		P-Ch		9			
Gate Resistance	R_G	$V_{GS} = 15 mV$, $f = 1.0 MHz$	N-Ch		1			Ω	
Input Capacitance	C_{iss}	N-Channel $V_{DS} = 10 V$, $V_{GS} = 0 V$, $f = 1.0 MHz$	N-Ch		650			pF	
				P-Ch		607			
Output Capacitance	C_{oss}		N-Ch		170			pF	
				P-Ch		165			
Reverse Transfer Capacitance	C_{rss}		N-Ch		80			pF	
				P-Ch		60			
Turn-On Delay Time	$t_{d(on)}$	N-Channel $V_{DD} = 10 V$, $I_D = 1 A$, $V_{GS} = 4.5 V$, $R_{GEN} = 6 \Omega$	N-Ch		8	16		ns	
				P-Ch		12	22		
Turn-On Rise Time	t_r		N-Ch		9	18		ns	
				P-Ch		11	20		
Turn-Off Delay Time	$t_{d(off)}$	P-Channel $V_{DD} = -10 V$, $I_D = -1 A$, $V_{GS} = -4.5 V$, $R_{GEN} = 6 \Omega$	N-Ch		16	29		ns	
				P-Ch		26	42		
Turn-Off Fall Time	t_f		N-Ch		7	14		ns	
				P-Ch		8	16		

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■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Testconditons	Min	Typ	Max	Unit
Total Gate Charge	Q _g	N-Channel V _{DS} = 10V, I _D = 3.6A, V _G S = 4.5V (Note 2)	N-Ch	7	10	nC
Gate-Source Charge			P-Ch	6	8	
Gate-Drain Charge	Q _{gd}	P-Channel V _{DS} = -10V, I _D = -2.6A, V _G S = -4.5V (Note 2)	N-Ch	1.3		nC
			P-Ch	1.2		
Maximum Continuous Drain-Source Diode Forward Current	I _S	V _G S = 0 V, I _S = 0.7A (Not 2) V _G S = 0 V, I _S = -0.7A (Not 2)	N-Ch	2.2		nC
Drain-Source Diode Forward Voltage	V _{SD}		P-Ch	1.6		
Diode Reverse Recovery Time	t _{rr}	N-Channel I _F = 3.6A, dI _F /dt = 100 A/μ s P-Channel I _F = -2.6A, dI _F /dt = 100 A/μ s	N-Ch	0.7	1.2	nS
Maximum Reverse Recovery Current	I _{rm}		P-Ch	-0.7	-1.2	
Diode Reverse Recovery Charge	Q _{rr}		N-Ch	16		A
			P-Ch	22		
			N-Ch	0.6		nC
			P-Ch	0.7		
			N-Ch	5		A
			P-Ch	8		

Notes:

1. R_{JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{JC} is guaranteed by design while R_{CA} is determined by the user's board design.



a) 76°C/W when mounted on a 1in² pad of 2 oz copper



b) 146°C/W when mounted on a minimum pad of 2 oz copper

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%